Search Notes

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Application/Control No.	Applicant(s)/Patent Under Reexamination
10735726	LEE, KYUNG-HA
Examiner	Art Unit
Haile. Awet A	2616

SEARCHED						
Class	Subclass	Date	Examiner			
370	512	3/31/2008	Awet Haile			
370	464	3/31/2008	Awet Haile			
370	470	3/31/2008	Awet Haile			
370	474	3/31/2008	Awet Haile			
370	441	3/31/2008	Awet Haile			

SEARCH NOTES				
Search Notes	Date	Examiner		
East search	3/31/2008	Awet Haile		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

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